

FORM 1449* INFORMATION DISCLOSURE STATEMENT IN AN APPLICATION <small>(Use several sheets if necessary)</small>		Docket Number: 10873.447USD1	Application Number: 09/842,487
<small>JUN 18 2001</small> <small>PTO-1449</small> <small>U.S. PATENT & TRADEMARK OFFICE</small>		Applicant: Ono et al.	
		Filing Date: April 25, 2001	Group Art Unit: Unknown

U.S. PATENT DOCUMENTS						
EXAMINER INITIAL	DOCUMENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<i>JMM</i>	US 6,001,724	Dec. 1999	Stansbury			
	US 5,994,212	Nov. 1999	Arakawa et al.			
	US 5,994,152	Nov. 1999	Khandros et al.			
	US 5,686,353	Nov. 1997	Yagi et al.			
	US 5,633,204	May 1997	Tago et al.			
	US 5,124,277	Jun. 1992	Tsumura			
FOREIGN PATENT DOCUMENTS						
	DOCUMENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION
						YES
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)						



EXAMINER: <i>James M. Miller</i>	DATE CONSIDERED: <i>4/21/02</i>
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form for next communication to the Applicant.	

April 25, 2001

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**INFORMATION DISCLOSURE STATEMENT
IN AN APPLICATION**

Docket Number: 10873.447USD1 Application Number: Unknown

Applicant: ONO et al.

Filing Date: April 25, 2001 Group Art Unit: 2812

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09/842487

04/25/01

U.S. PATENT DOCUMENTS

FOREIGN PATENT DOCUMENTS

	DOCUMENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

	Publication (partial): 7 th Electron Device Reliability Symposium; November, 1997; Pages 89-94, "The effect of stud bumping about the MOSFETs on Device Reliability" by N. Shimoyama, et al., NTT System Electronics Laboratories
	Publication (partial): Electronics, Electronic Packaging Technology vol. 12, No. 8, August, 1996; pages 78-83, "Current Tendency of IC chip packaging technology" by Susan Honda, S.C. Laboratory
	

EXAMINER

DATE CONSIDERED

4/26/02

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